
Specifikacija za preskušanje simetričnega in koaksialnega okablenja v informacijski tehnologiji - 4. del: Nameščeno uravnoteženo enoparno ožičenje, kot je določeno v standardu ISO/IEC 11801-1 in sorodnih standardih

Specification for the testing of balanced and coaxial information technology cabling - Part 4: Installed balanced single-pair cabling as specified in ISO/IEC 11801-1 and related standards

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Spécification relative aux essais des câblages symétriques et coaxiaux des technologies de l'information - Partie 4: Câblages symétriques à paire unique installés selon les spécifications de l'ISO/IEC 11801-1 et des normes connexes

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TITLE:
Specification for the testing of balanced and coaxial information technology cabling - Part 4: Installed balanced single-pair cabling as specified in ISO/IEC 11801-1 and related standards

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